Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination
09/826,002	MIYASHITA ET AL.

Examiner

Hung H. Lam

Applicant(s)/Patent under Reexamination MIYASHITA ET AL. Art Unit

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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	Search (see ory printout)	10/26/2005	HL

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Inventor Search (Text search only - see search history printout)	10/26/2005	HL
DAVIS OMETZ	10/26/2005	HL
NHAN TRAN	10/26/2005	HL
TUAN HO	10/26/2005	HL
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